

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
217717US0SERIAL NO.
10/026,641

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Yasuhiro DOI, et al.

FILING DATE

12/27/01

GROUP

1615

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>[initials]</i>	AA	5,310,758	05/10/94	YOROZU, et al.	<div>TECH CENTER 1600/2900 OCT 24 2002 RECEIVED</div>		
	AB	5,411,731	05/02/95	TANAKA, et al.			
	AC	5,389,678	02/14/95	YOROZU, et al.			
<i>[initials]</i>	AD	5,858,936	01/12/99	TAMURA, et al.			
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
	AO				
	AP				
	AQ				
	AR				
	AS				
	AT				
	AU				
	AV				

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

Examiner

[Signature]

Date Considered

12/17/02

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
217717US0SERIAL NO.
10/026,841

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Yasuhiro DOI, et al.FILING DATE
December 27, 2001GROUP
161

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
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	AG						
	AH						
	AI						
	AJ						
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	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
2	AO	6-107524	04/19/94	JAPAN (with English Abstract)		X
	AP	6-178928	06/28/94	JAPAN (with English Abstract)		X
	AQ	WO 96/03483	02/08/96	WIPO		
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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